

U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Gross et al.; "Thermosensoric Localization of Defects in CIS Solar Modules", 26th PVSC, Sept. 30-Oct. 3, 1997, Anaheim CA, pages 551-554.			
	V	King et al.; "Applications for infrared imaging equipment in photovoltaic cell, module, and system testing"; 28th PVSC, Sept. 15- 22, 2000; Anchorage, AK; pages 1487-1490.			
	w	Breitenstein et al.; "Imaging the Local Forwrad Current Density of Solar Cells By Dynamic Precision Contact Thermography"; 1st WCPEC, Dec. 5-9, 1994, Hawaii; pages 1633-1636.			
	x /	Nowlan et al., "Automated Solar Cell Assembly Teamed Process Research, National Renewable Energy Laboratory (NREL)(Feb. 1996)			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.